

| L Number | Hits | Search Text | DB | Time stamp |
|-------------|------|--|---|---------------------|
| 1 | 38 | ueda near2 tetsuzo.in. | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2004/02/22 14:17 |
| - | 24 | iii near2 nitride and (both adj side) same deposit\$4 | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2002/12/31 10:20 |
| - | 78 | iii near2 nitride and (top same bottom) same deposit\$4 | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2002/12/31 10:25 |
| - | 96 | double near2 sid\$2 near2 (epitax\$4 or deposit\$4) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2002/12/31 10:27 |
| - | 4 | (double near2 sid\$2 near2 (epitax\$4 or deposit\$4)) and 117/\$4.ccls. | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2002/12/31 10:37 |
| - | 0 | 5356831.pn. and remov\$3 near2 substrate | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2002/12/31 10:40 |
| - | 2 | 5356831.pn. and substrate | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2002/12/31 10:40 |
| - | 353 | olsen.in. and bow\$3 | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2004/02/09 18:08 |
| - | 2 | olsen.in. and bow\$3 near10 wafer | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2004/02/09 18:09 |
| - | 1280 | bow\$3 near10 wafer | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2004/02/09 18:09 |
| - | 38 | bow\$3 near10 wafer same nitride | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2004/02/10 11:05 |
| - | 96 | bow\$3 near10 wafer near10 flat\$4 | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2004/02/10 13:47 |
| - | 687 | deposit\$ near15 wafer near10 flat\$4 | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2004/02/10 13:50 |
| - | 70 | deposit\$ near15 wafer near10 (flatten or flattening or flattens) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB | 2004/02/10 13:50 |

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|---|------|--|---|---------------------|
| - | 3 | 5562770.URPN. | USPAT | 2004/02/10 13:53 |
| - | 12 | ("3458369" "3808674" "3821033" "3997368" "4079506" "4159214" "4415373" "4631804" "4805071" "4830984" "5158907" "5319570").PN. | USPAT | 2004/02/10 13:54 |
| - | 225 | direct near5 heat\$4 and 117/\$.ccls. | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB | 2004/02/10 14:32 |
| - | 66 | direct near5 heat\$4 and 117/\$.ccls. and (chemical adj vapor adj deposition or cvd) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB | 2004/02/10 14:36 |
| - | 1911 | without near4 heat near2 sink | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB | 2004/02/10 14:36 |
| - | 77 | (without near4 heat near2 sink) and (cvd or chemical adj vapor adj deposition) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB | 2004/02/10 14:38 |
| - | 6 | ((without near4 heat near2 sink) and (cvd or chemical adj vapor adj deposition)) and 117/\$.ccls. | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB | 2004/02/10 14:37 |
| - | 5 | (without near4 heat near2 sink) same (direct\$4 near2 heat\$4) and (cvd or chemical adj vapor adj deposition) | USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM TDB | 2004/02/10 14:38 |